Certificate





No.: 968/FSP 2747.00/24

Product tested Diagnostic software test library

Certificate holder

GigaDevice
Semiconductor Inc.
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DISTRICT,
100094 BEIJING
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Type designation GD32H7xx_STL Diagnostic software test library for GD32H7xx 32-bit

Arm® Cortex® - M7 microcontrollers as listed in the current "Revision List".

Codes and standards IEC 61508-1:2010 IEC 61508-3:2010

IEC 61508-2:2010, Annex A

Intended application The GigaDevice GD32H7xx STL diagnostic software test library for

GD32H7xx semiconductor devices based on Arm® Cortex® - M7 complies

with the requirements of systematic capability 3 (SC3) according

to IEC 61508.

A diagnostic coverage (DC) of medium (90%) for CPU, SRAM and a diagnostic coverage (DC) of high (99%) for FLASH is achievable. Therefore, the software test library (STL) can be used in safety-related

applications up to SIL 3 in accordance with IEC 61508.

Specific requirements The instructions of the Safety Manual shall be considered.

The issue of this certificate is based upon an evaluation in accordance with the Certification Program CERT FSP1 V3.0:2020 in its actual version, whose results are documented in Report No. 968/FSP 2747.00/24 dated 2024-07-03. This certificate is valid only for products, which are identical with the product tested. Issued by the certification body accredited by DAkkS according to DIN EN ISO/IEC 17065. The accreditation is only valid for the scope listed in the annex to the accreditation certificate D-ZE-11052-02-00.

TÜV Rheinland Industrie Service GmbH Bereich Automation

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Certification Body Safety & Security for Automation & Grid

Dipl.-Ing. Thomas Steffens



Köln, 2024-07-03



